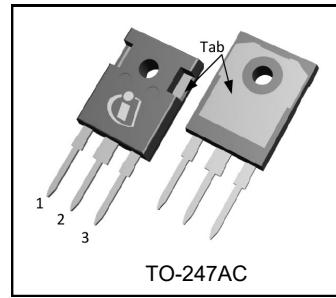
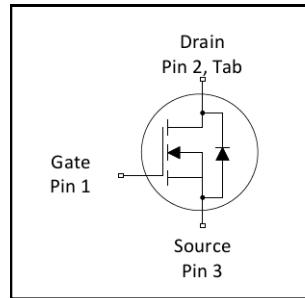


V_{DSS}	300V
R_{DS(on)} typ.	25.5mΩ
max.	32mΩ
I_D	70A



Applications

- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and di/dt Capability
- Lead-Free

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRFP4868PbF	TO-247AC	Tube	25	IRFP4868PbF

Absolute Maximum Ratings

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	70	A
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	49	
I _{DM}	Pulsed Drain Current ①	280	W
P _D @ T _C = 25°C	Maximum Power Dissipation	517	
	Linear Derating Factor	3.4	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
T _J	Operating Junction and	-55 to + 175	°C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	mJ
	Mounting torque, 6-32 or M3 screw	10lbf.in (1.1N·m)	

Avalanche Characteristics

E _{AS} (Thermally limited)	Single Pulse Avalanche Energy ②	1093	mJ
I _{AR}	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	A
E _{AR}	Repetitive Avalanche Energy ①		

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
R _{θJC}	Junction-to-Case ⑦⑧	—	0.29	°C/W
R _{θCS}	Case-to-Sink, Flat Greased Surface	0.24	—	
R _{θJA}	Junction-to-Ambient	—	40	

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	300	—	—	V	$V_{GS} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.29	—	V/ $^\circ\text{C}$	Reference to 25°C , $I_D = 5\text{mA}$ ①
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	25.5	32	$\text{m}\Omega$	$V_{GS} = 10\text{V}$, $I_D = 42\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	3.0	—	5.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	20	—	μA	$V_{DS} = 300\text{V}$, $V_{GS} = 0\text{V}$
						$V_{DS} = 300\text{V}$, $V_{GS} = 0\text{V}$, $T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	100	—	nA	$V_{GS} = 20\text{V}$
						$V_{GS} = -20\text{V}$
R_G	Internal Gate Resistance	—	1.1	—	Ω	

Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
g_{fs}	Forward Transconductance	80	—	—	S	$V_{DS} = 50\text{V}$, $I_D = 42\text{A}$
Q_g	Total Gate Charge	—	180	270	nC	$I_D = 42\text{A}$
Q_{gs}	Gate-to-Source Charge	—	60	—		$V_{DS} = 150\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	57	—		$V_{GS} = 10\text{V}$ ④
Q_{sync}	Total Gate Charge Sync. ($Q_g - Q_{gd}$)	—	123	—		$I_D = 42\text{A}$, $V_{DS} = 0\text{V}$, $V_{GS} = 10\text{V}$
$t_{d(on)}$	Turn-On Delay Time	—	24	—	ns	$V_{DD} = 195\text{V}$
t_r	Rise Time	—	50	—		$I_D = 42\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	62	—		$R_G = 1.0\Omega$
t_f	Fall Time	—	45	—		$V_{GS} = 10\text{V}$ ④
C_{iss}	Input Capacitance	—	10774	—	pF	$V_{GS} = 0\text{V}$
C_{oss}	Output Capacitance	—	612	—		$V_{DS} = 50\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	193	—		$f = 1.0\text{ MHz}$, See Fig. 5
C_{oss} eff. (ER)	Effective Output Capacitance (Energy Related) ⑥	—	406	—		$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V}$ to 240V ⑥, See Fig. 11
C_{oss} eff. (TR)	Effective Output Capacitance (Time Related) ⑤	—	710	—		$V_{GS} = 0\text{V}$, $V_{DS} = 0\text{V}$ to 240V ⑤

Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	70	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	280	A	
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$, $I_S = 42\text{A}$, $V_{GS} = 0\text{V}$ ④
dv/dt	Peak Diode Recovery ③	—	7.3	—	V/ns	$T_J = 25^\circ\text{C}$, $I_S = 42\text{A}$, $V_{DS} = 300\text{V}$
t_{rr}	Reverse Recovery Time	—	351	—	ns	$T_J = 25^\circ\text{C}$
						$T_J = 125^\circ\text{C}$ $V_R = 255\text{V}$, $I_F = 42\text{A}$
Q_{rr}	Reverse Recovery Charge	—	2520	—	nC	$T_J = 25^\circ\text{C}$ $di/dt = 100\text{A}/\mu\text{s}$ ④
						$T_J = 125^\circ\text{C}$
I_{RRM}	Reverse Recovery Current	—	16	—	A	$T_J = 25^\circ\text{C}$
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes:

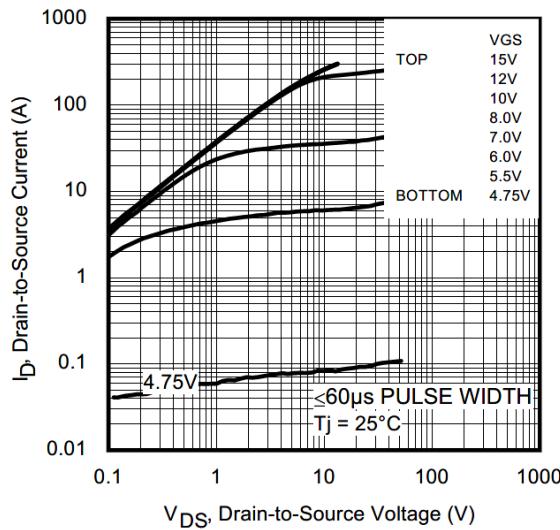
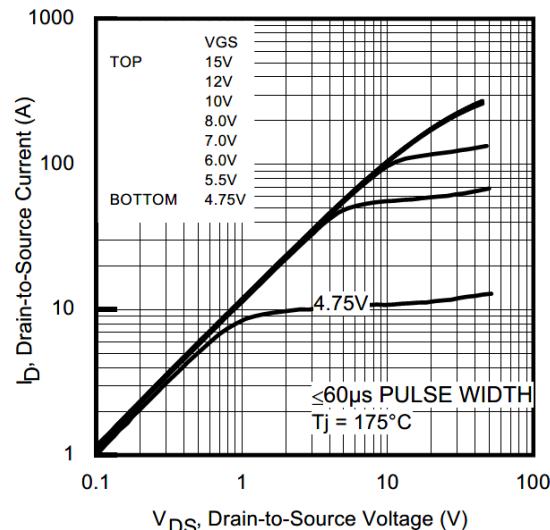
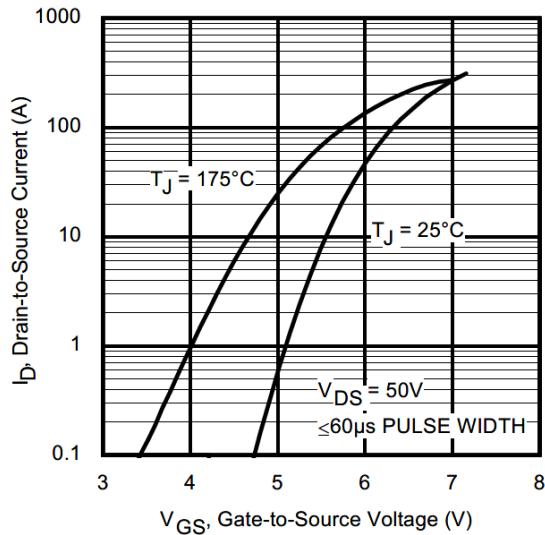
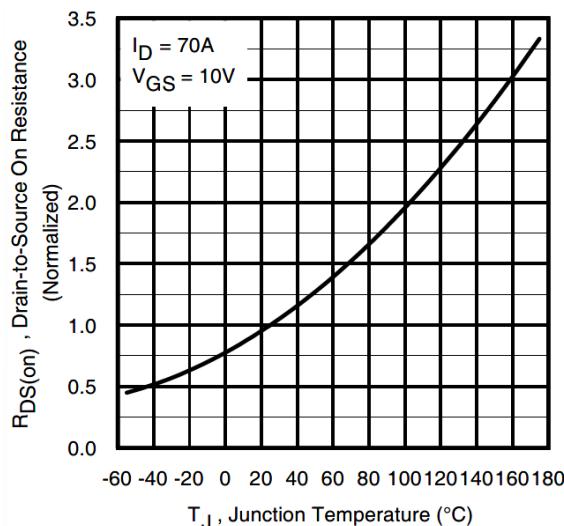
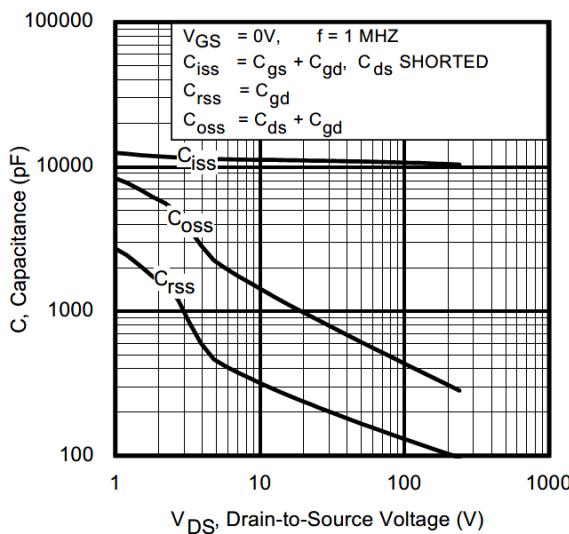
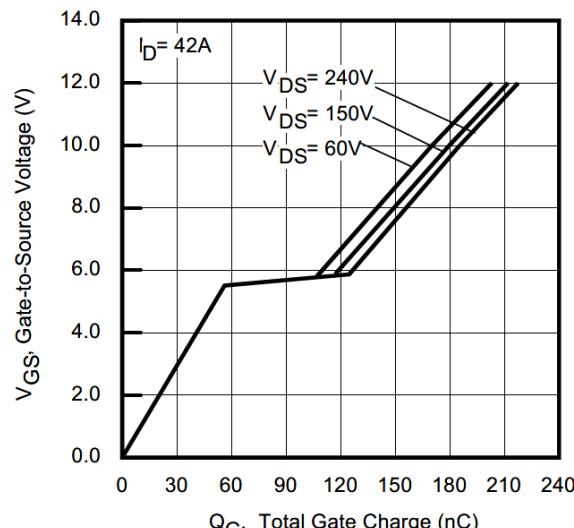
- ① Repetitive rating; pulse width limited by max. Junction temperature.
- ② Limited by $T_{J\text{max}}$, starting $T_J = 25^\circ\text{C}$, $L = 1.2\text{mH}$ $R_G = 50\Omega$, $I_{AS} = 42\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value.
- ③ $I_{SD} \leq 42\text{A}$, $di/dt \leq 1706\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$.
- ④ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.

⑤ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

⑥ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .

⑦ R_θ is measured at T_J approximately 90°C .

⑧ $R_{\theta,\text{JC}}$ value shown is at time zero.

**Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Normalized On-Resistance vs. Temperature**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

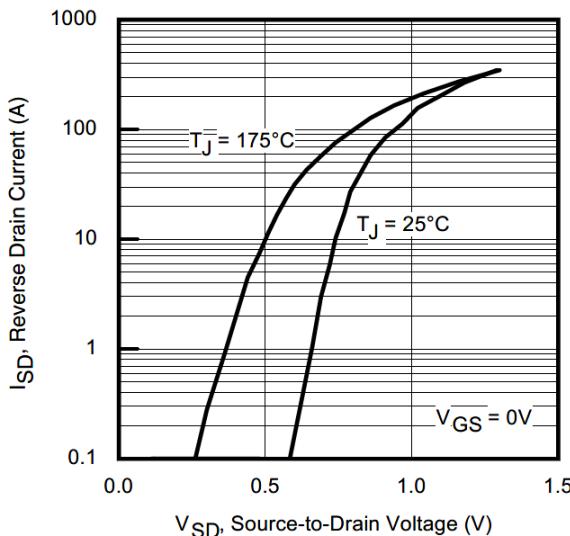


Fig 7. Typical Source-to-Drain Diode Forward Voltage

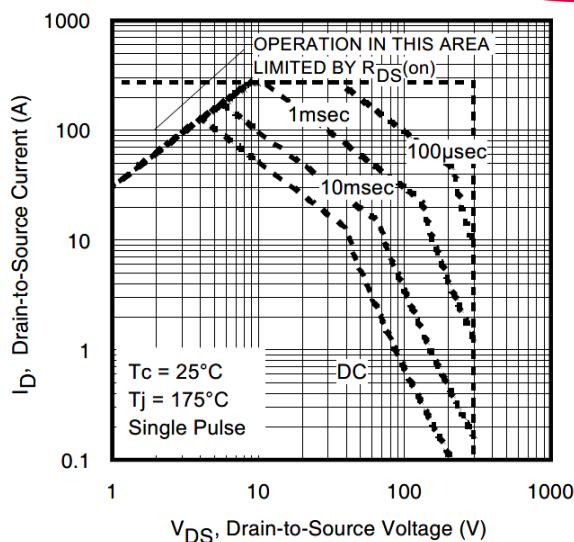


Fig 8. Maximum Safe Operating Area

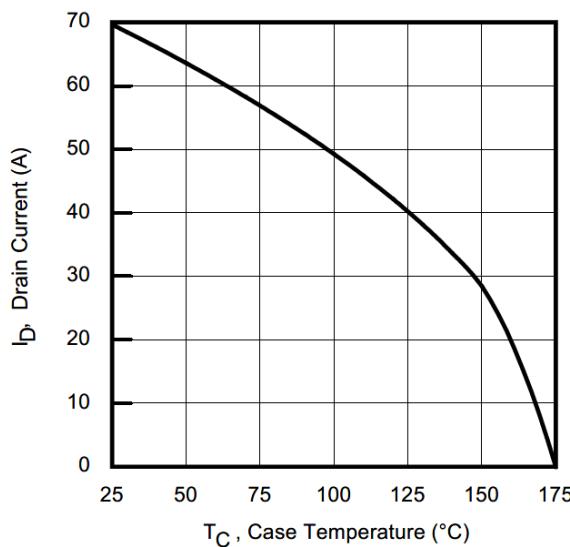


Fig 9. Maximum Drain Current vs. Case Temperature

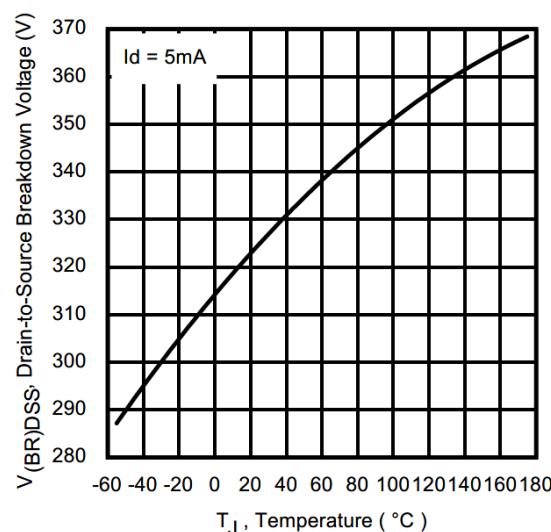


Fig 10. Drain-to-Source Breakdown Voltage

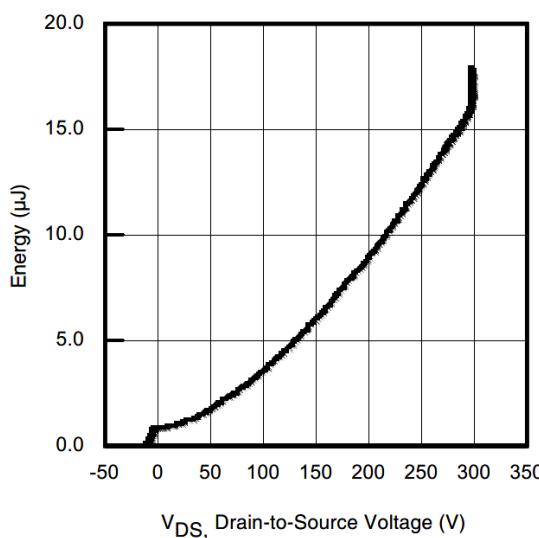


Fig 11. Typical Coss Stored Energy

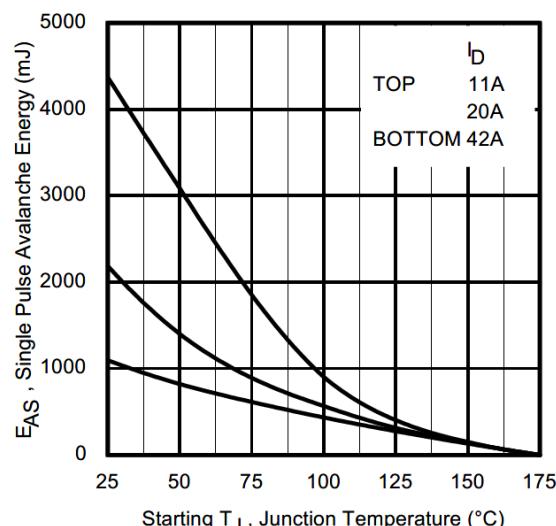


Fig 12. Maximum Avalanche Energy vs. Drain Current

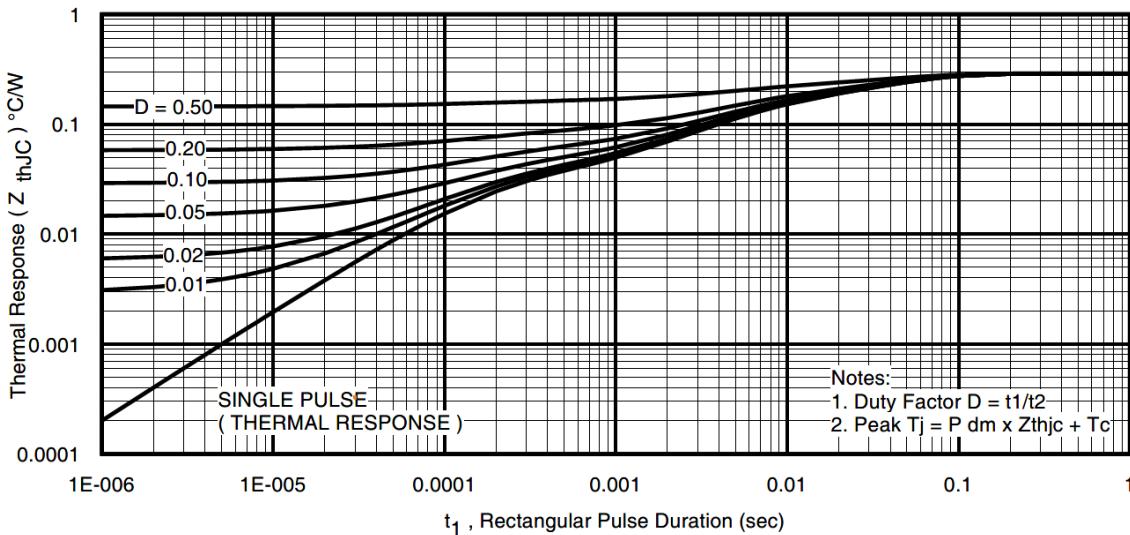


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

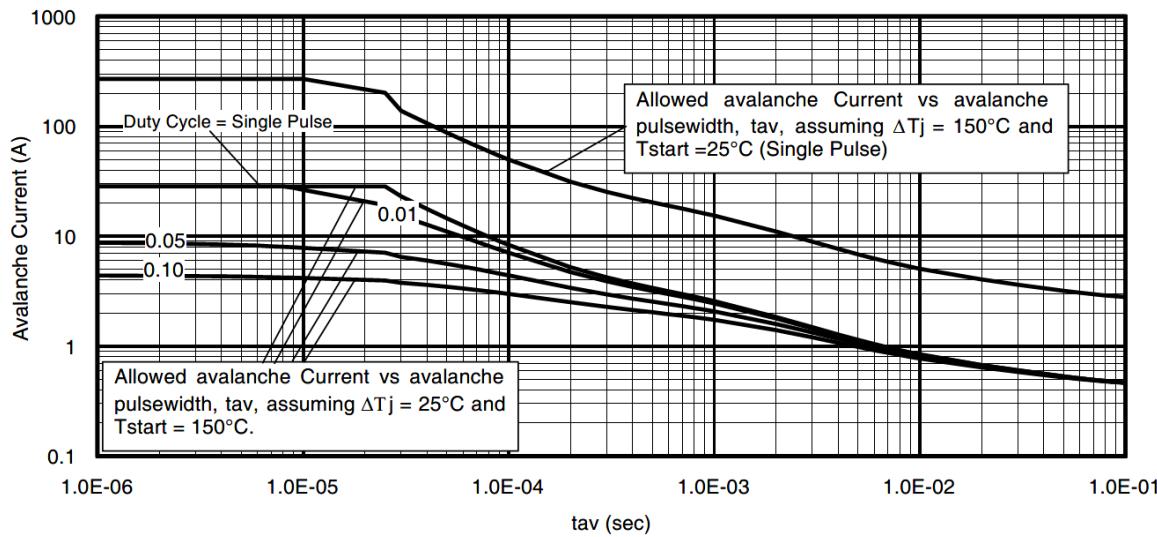


Fig 14. Typical Avalanche Current vs. Pulsewidth

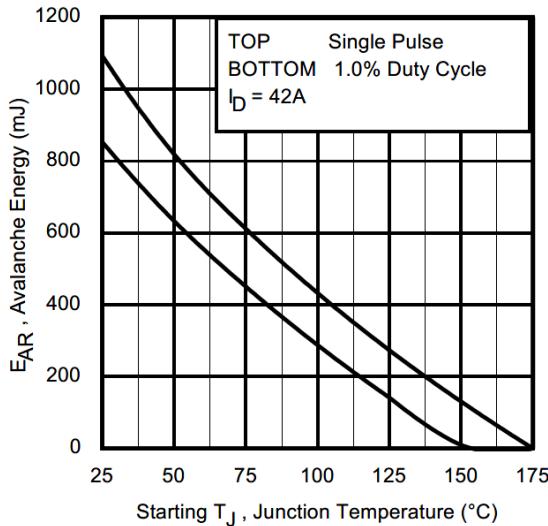


Fig 15. Maximum Avalanche Energy vs. Temperature

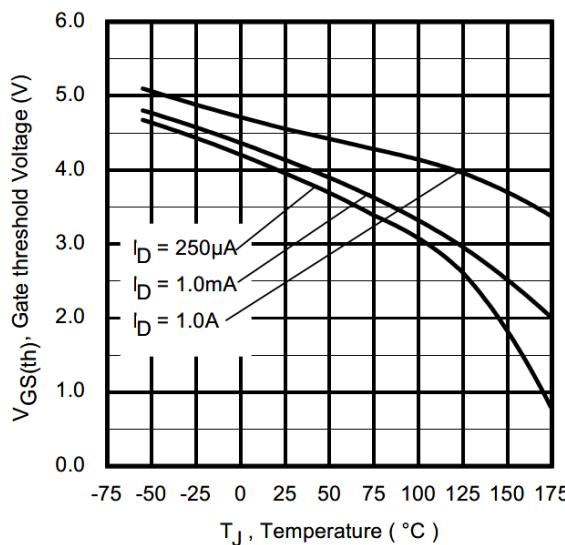
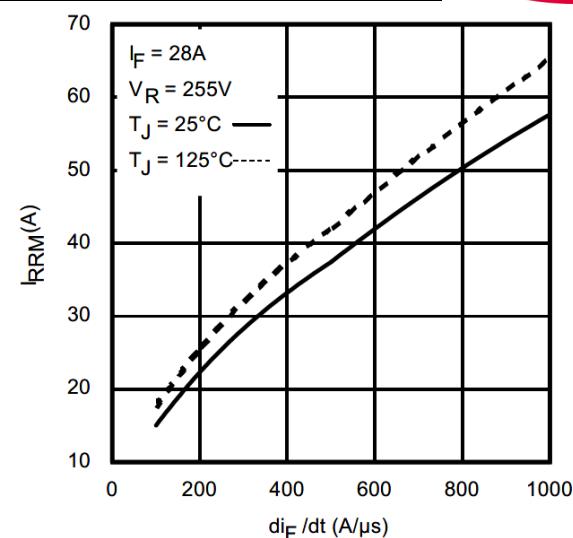
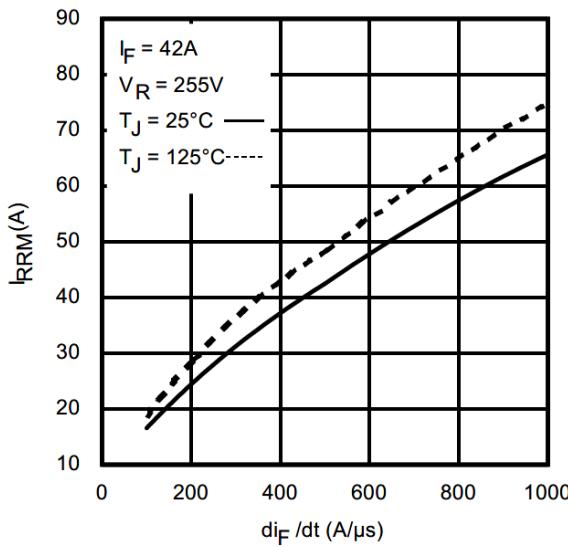
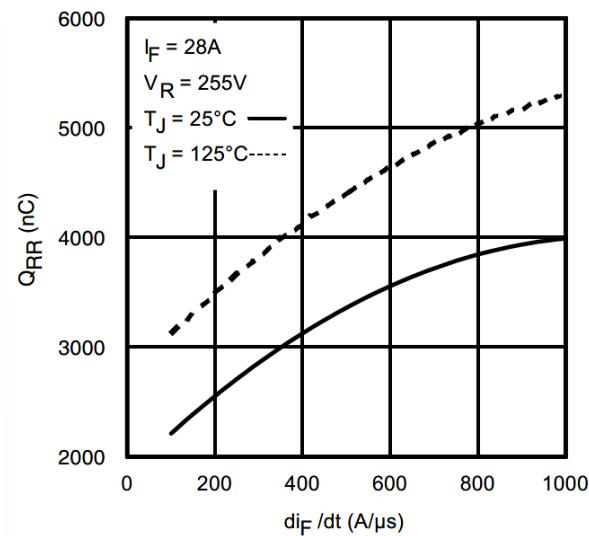
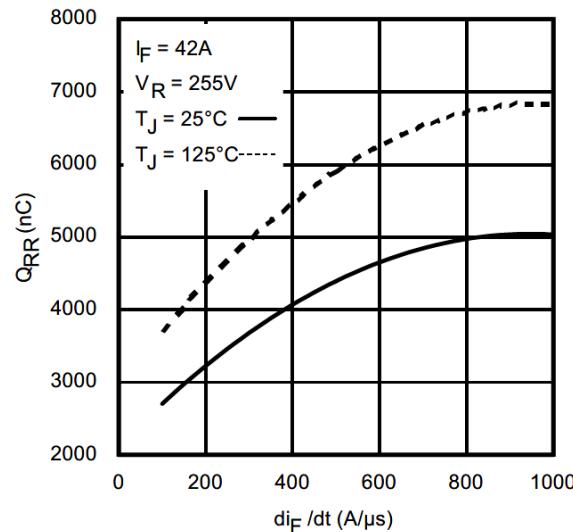
**Notes on Repetitive Avalanche Curves , Figures 14, 15:
(For further info, see AN-1005 at www.irf.com)**

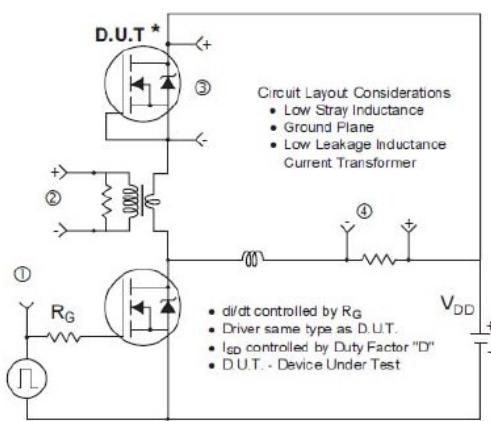
1. Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
4. $P_{D(ave)}$ = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6. I_{av} = Allowable avalanche current.
7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
- t_{av} = Average time in avalanche.
- D = Duty cycle in avalanche = $t_{av} \cdot f$
- $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

**Fig. 16** Threshold Voltage vs. Temperature**Fig. 17** Typical Recovery Current vs. di_F/dt **Fig 18.** Typical Recovery Current vs. di_F/dt **Fig 19.** Typical Stored Charge vs. di_F/dt **Fig 20.** Typical Stored Charge vs. di_F/dt



* Reverse Polarity of D.U.T for P-Channel

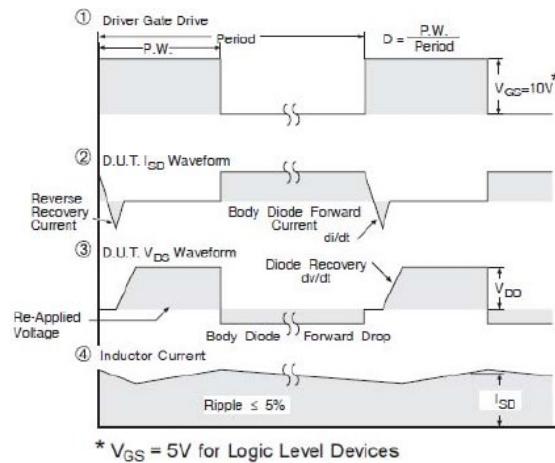


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

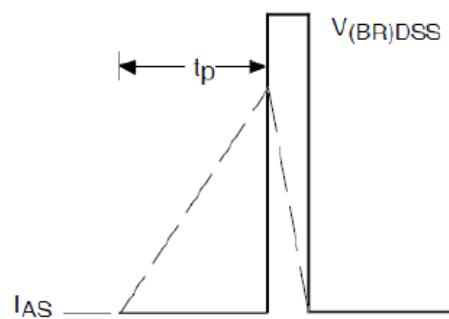
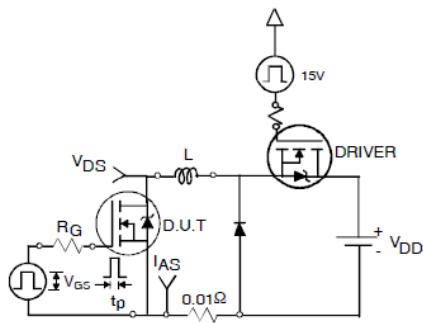


Fig 22a. Unclamped Inductive Test Circuit

Fig 22b. Unclamped Inductive Waveforms

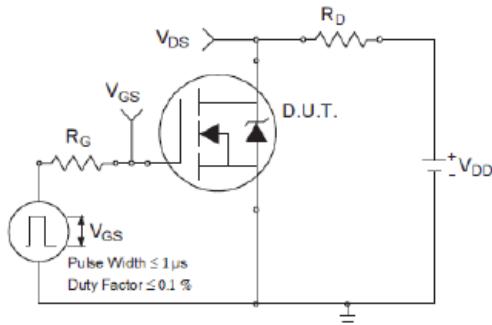


Fig 23a. Switching Time Test Circuit

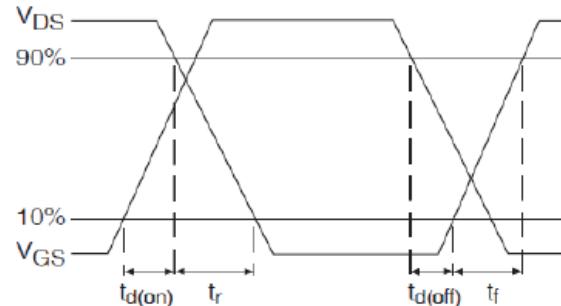


Fig 23b. Switching Time Waveforms

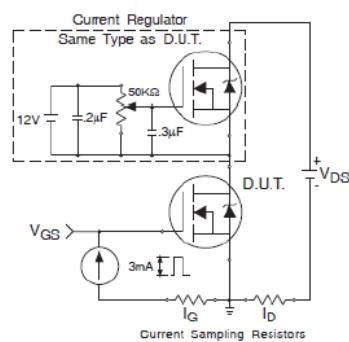


Fig 24a. Gate Charge Test Circuit

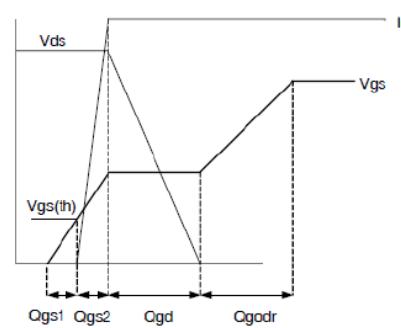
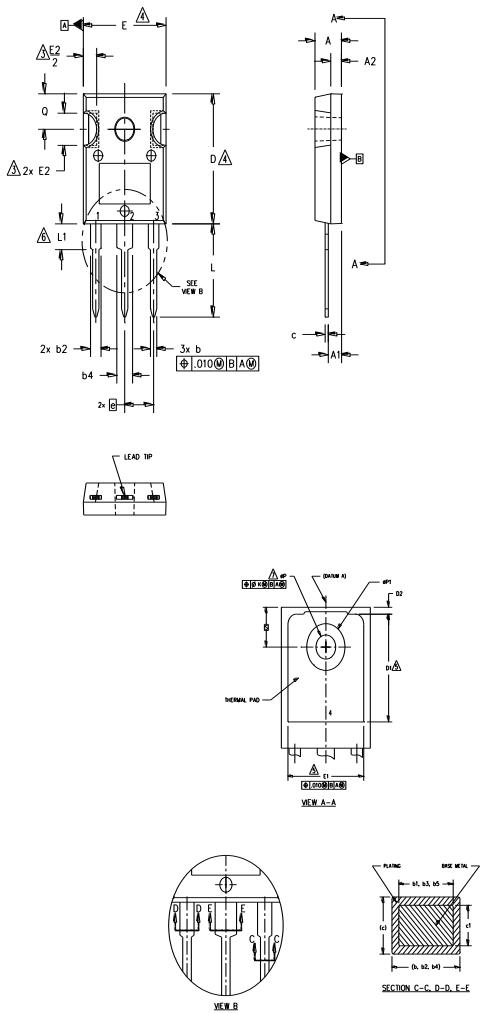


Fig 24b. Gate Charge Waveform

TO-247AC Package Outline (Dimensions are



NOTES

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
 2. DIMENSIONS ARE SHOWN IN INCHES.
 3. CONTOUR OF SLOT OPTIONAL.
 4. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 5. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.
 6. LEAD FINISH UNCONTROLLED IN L1.
 7. ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 ° TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.
 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

SYMBOL	DIMENSIONS				NOTES	
	INCHES		MILLIMETERS			
	MIN.	MAX.	MIN.	MAX.		
A	.183	.209	4.65	5.31		
A1	.087	.102	2.21	2.59		
A2	.059	.098	1.50	2.49		
b	.039	.055	0.99	1.40		
b1	.039	.053	0.99	1.35		
b2	.065	.094	1.65	2.39		
b3	.065	.092	1.65	2.34		
b4	.102	.135	2.59	3.43		
b5	.102	.133	2.59	3.38		
c	.015	.035	0.38	0.89		
c1	.015	.033	0.38	0.84		
D	.776	.815	19.71	20.70	4	
D1	.515	—	13.08	—	5	
D2	.020	.053	0.51	1.35		
E	.602	.625	15.29	15.87	4	
E1	.530	—	13.46	—		
E2	.178	.216	4.52	5.49		
e	.215 BSC		5.46 BSC			
øk	.010		0.25			
L	.559	.634	14.20	16.10		
L1	.146	.169	3.71	4.29		
øP	.140	.144	3.56	3.66		
øP1	—	.291	—	7.39		
Q	.209	.224	5.31	5.69		
S	.217 BSC		5.51 BSC			

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
 - 2.- DRAIN
 - 3.- SOURCE
 - 4.- DRAIN

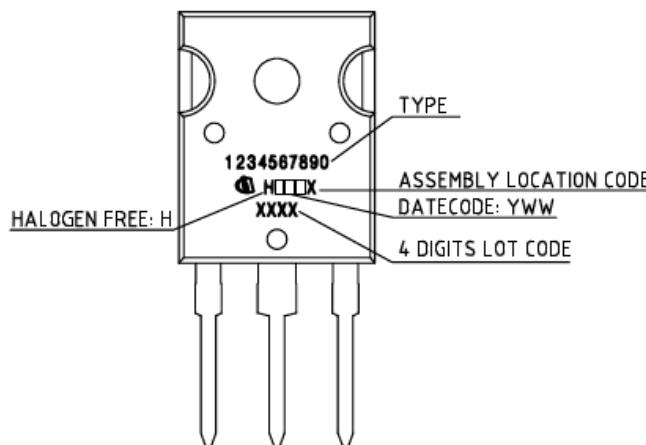
IGBTs, CoPACK

- 1.- GATE
 - 2.- COLLECTOR
 - 3.- Emitter
 - 4.- COLLECTOR

DIODES

- 1.- ANODE/OPEN
 - 2.- CATHODE
 - 3.- ANODE

TO-247AC Part Marking Information



TO-247AC package is not recommended for Surface Mount Application.

Qualification information

Qualification level	Industrial (per JEDEC JESD47F) [†]	
Moisture Sensitivity Level	TO-247AC	N/A
RoHS compliant	Yes	

[†] Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Rev.	Comments
06/21/2017	2.1	<ul style="list-style-type: none">Changed datasheet with Infineon logo-all pagesCorrected Package outline on page 8.Added disclaimer on last page.
06/10/2024	2.2	<ul style="list-style-type: none">Update datasheet to Infineon formatCorrected trise to latest lab measurements
10/18/2024	2.3	<ul style="list-style-type: none">Updated Part marking –page 8

Trademarks

All referenced product or service names and trademarks are the property of their respective owners.

We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: erratum@infineon.com

Published by

Infineon Technologies AG

81726 München, Germany

© 2024 Infineon Technologies AG

All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics (“Beschaffenheitsgarantie”).

With respect to any examples, hints or any typical values stated herein and/or any information regarding the application of the product, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

In addition, any information given in this document is subject to customer's compliance with its obligations stated in this document and any applicable legal requirements, norms and standards concerning customer's products and any use of the product of Infineon Technologies in customer's applications.

The data contained in this document is exclusively intended for technically trained staff. It is the responsibility of customer's technical departments to evaluate the suitability of the product for the intended application and the completeness of the product information given in this document with respect to such application.

Information

For further information on the product, technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies office (www.infineon.com).

Warnings

Due to technical requirements products may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies office.

The Infineon Technologies component described in this Data Sheet may be used in life support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

单击下面可查看定价，库存，交付和生命周期等信息

[>>Infineon\(英飞凌\)](#)